

# Logarithmic Digitally Controlled Potentiometer (XDCP™)

Data Sheet

January 30, 2009

FN8223.2

# Terminal Voltage ±5V, 100 Taps, Log Taper

### Description

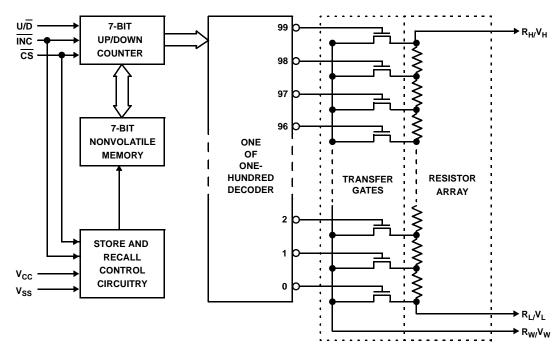
The Intersil X9C303 is a digitally controlled potentiometer (XDCP). The device consists of a resistor array, wiper switches, a control section, and nonvolatile memory. The wiper position is controlled by a three-wire interface.

The resistor array is composed of 99 resistive elements. Between each element and at either end are tap points accessible to the wiper terminal. The position of the wiper element is controlled by the  $\overline{CS}$ ,  $U/\overline{D}$ , and  $\overline{INC}$  inputs. The position of the wiper can be stored in nonvolatile memory and then be recalled upon a subsequent power-up operation.

The device can be used as a three-terminal potentiometer or as a two-terminal variable resistor in a wide variety of applications ranging from control, to signal processing, to parameter adjustment. Digitally-controlled potentiometers provide three powerful application advantages; (1) the variability and reliability of a solid-state potentiometer, (2) the flexibility of computer-based digital controls, and (3) the use of nonvolatile memory for potentiometer settings retention.

### Features

- Solid-state potentiometer
- Three-wire serial interface
- 100 wiper tap points
- Wiper position stored in nonvolatile memory and recalled on power-up
- 99 resistive elements, log taper
  - Temperature compensated
  - End-to-end resistance, 32kΩ ±15%
  - Terminal voltages, ±5V
- Low power CMOS
  - V<sub>CC</sub> = 5V
  - Active current, 3mA max.
  - Standby current, 750µA max.
- High reliability
  - Endurance, 100,000 data changes per bit
  - Register data retention, 100 years
- Packages
  - 8 Ld TSSOP
  - 8 Ld SOIC
  - 8 Ld PDIP
- Pb-free available (RoHS compliant)



CAUTION: These devices are sensitive to electrostatic discharge; follow proper IC Handling Procedures. 1-888-INTERSIL or 1-888-468-3774 | Intersil (and design) is a registered trademark of Intersil Americas Inc. XDCP is a trademark of Intersil Americas Inc. 2005, 2007, 2009. All Rights Reserved All other trademarks mentioned are the property of their respective owners.

# Block Diagram

1

All other trademarks mentioned are the property of th

# **Ordering Information**

PART NUMBER	PART MARKING	TEMP. RANGE (°C)	PACKAGE	PKG. DWG. #
X9C303P	X9C303P	0 to +70	8 Ld PDIP	MDP0031
X9C303PI	X9C303P I	-40 to +85	8 Ld PDIP	MDP0031
X9C303PIZ (Notes 1, 2)	X9C303P ZI	-40 to +85	8 Ld PDIP (300 mil) (Pb-free)	MDP0031
X9C303PZ (Notes 1, 2)	X9C303P Z	0 to +70	8 Ld PDIP (300 mil) (Pb-free)	MDP0031
X9C303S8*, **	X9C303S	0 to +70	8 Ld SOIC (150 mil)	MDP0027
X9C303S8I*	X9C303S I	-40 to +85	8 Ld SOIC (150 mil)	MDP0027
X9C303S8IZ* (Note 1)	X9C303S ZI	-40 to +85	8 Ld SOIC (150 mil) (Pb-free)	MDP0027
X9C303S8Z* (Note 1)	X9C303S Z	0 to +70	8 Ld SOIC (150 mil) (Pb-free)	MDP0027
X9C303V8* <sup>,</sup> **	9C303	0 to +70	8 Ld TSSOP (4.4mm)	M8.173
X9C303V8I*	C303 I	-40 to +85	8 Ld TSSOP (4.4mm)	M8.173
X9C303V8IZ* (Note 1)	C303 IZ	-40 to +85	8 Ld TSSOP (4.4mm) (Pb-free)	M8.173
X9C303V8Z* (Note 1)	9C303 Z	0 to +70	8 Ld TSSOP (4.4mm) (Pb-free)	M8.173
X9C303S8I-2.7	X9C303S G	-40 to +85	8 Ld SOIC (150 mil)	MDP0027
X9C303S8IZ-2.7 (Note 1)	X9C303S ZG	-40 to +85	8 Ld SOIC (150 mil) (Pb-free)	MDP0027

\*Add "T1" suffix for tape and reel. Please refer to TB347 for details on reel specifications.

\*\*Add "T2" suffix for tape and reel. Please refer to TB347 for details on reel specifications.

NOTES:

 These Intersil Pb-free plastic packaged products employ special Pb-free material sets, molding compounds/die attach materials, and 100% matte tin plate plus anneal (e3 termination finish, which is RoHS compliant and compatible with both SnPb and Pb-free soldering operations). Intersil Pb-free products are MSL classified at Pb-free peak reflow temperatures that meet or exceed the Pb-free requirements of IPC/JEDEC J STD-020.

2. Pb-free PDIPs can be used for through hole wave solder processing only. They are not intended for use in Reflow solder processing applications.

# **Pin Descriptions**

#### V<sub>H</sub> and V<sub>L</sub>

The high (V<sub>H</sub>) and low (V<sub>L</sub>) terminals of the device are equivalent to the fixed terminals of a mechanical potentiometer. The minimum voltage is –5V and the maximum is +5V. It should be noted that the terminology of V<sub>L</sub> and V<sub>H</sub> references the relative position of the terminal in relation to wiper movement direction selected by the U/ $\overline{D}$  input and not the voltage potential on the terminal.

### V<sub>W</sub>

 $V_W$  is the wiper terminal, equivalent to the movable terminal of a mechanical potentiometer. The position of the wiper within the array is determined by the control inputs. The wiper terminal series resistance is typically  $40\Omega$ .

# Up/Down (U/D)

The  $U/\overline{D}$  input controls the direction of the wiper movement and whether the counter is incremented or decremented.

### Increment (INC)

The  $\overline{\text{INC}}$  input is negative-edge triggered. Toggling  $\overline{\text{INC}}$  will move the wiper and either increment or decrement the counter in the direction indicated by the logic level on the U/D input.

# Chip Select (CS)

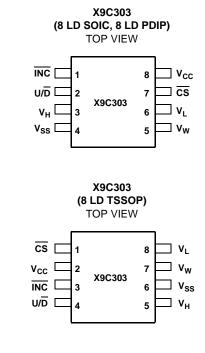
The device is selected when the  $\overline{CS}$  input is LOW. The current counter value is stored in nonvolatile memory when  $\overline{CS}$  is

2

intersil

returned HIGH while the INC input is also HIGH. After the store operation is complete, the device will be placed in the low power standby mode until the device is selected once again.

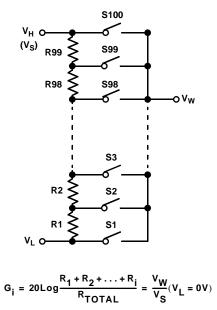
# **Pinouts**



# Pin Names

SYMBOL	DESCRIPTION
VH	High Terminal (Potentiometer)
VW	Wiper Terminal (Potentiometer)
VL	Low Terminal (Potentiometer)
V <sub>SS</sub>	Ground
VCC	Supply Voltage
U/D	Up/Down Control Input
INC	Increment Control Input
CS	Chip Select Control Input
NC	No Connection

# Potentiometer Relationships



(REFER TEST CIRCUIT 1)

# Principles of Operation

There are three sections of the X9C303: the input control, counter and decode section; the nonvolatile memory; and the resistor array. The input control section operates just like an up/down counter. The output of this counter is decoded to turn on a single electronic switch connecting a point on the resistor array to the wiper output. Under the proper conditions, the contents of the counter can be stored in nonvolatile memory and retained for future use. The resistor array is comprised of 99 individual resistors connected in series. At either end of the array and between each resistor is an electronic switch that transfers the potential at that point to the wiper.

The wiper, when at either fixed terminal, acts like its mechanical equivalent and does not move beyond the last position. That is, the counter does not wrap around when clocked to either extreme. The electronic switches on the device operate in a "make before break" mode when the wiper changes tap positions. If the wiper is moved several positions, multiple taps are connected to the wiper for  $t_{\rm IW}$  (INC to  $V_W$  change). The  $R_{\rm TOTAL}$  value for the device can temporarily be reduced by a significant amount if the wiper is moved several positions.

When the device is powered-down, the last counter position stored will be maintained in the nonvolatile memory. When power is restored, the contents of the memory are recalled and the counter is reset to the value last stored.

### Instructions and Programming

The  $\overline{INC}$ ,  $U/\overline{D}$  and  $\overline{CS}$  inputs control the movement of the wiper along the resistor array. With  $\overline{CS}$  set LOW, the device is selected and enabled to respond to the  $U/\overline{D}$  and  $\overline{INC}$  inputs. HIGH to LOW transitions on  $\overline{INC}$  will increment or decrement (depending on the state of the  $U/\overline{D}$  input) a seven-bit counter. The output of this counter is decoded to select one of one-hundred wiper positions along the resistive array.

The value of the counter is stored in nonvolatile memory whenever  $\overline{\text{CS}}$  transitions HIGH while the  $\overline{\text{INC}}$  input is also HIGH.

The system may select the X9C303, move the wiper, and deselect the device without having to store the latest wiper position in nonvolatile memory. The wiper movement is performed as previously described ; once the new position is reached, the system would the keep INC LOW while taking CS HIGH. The new wiper position would be maintained until changed by the system or until a power-down/up cycle recalled the previously stored data.

This would allow the system to always power-up to a preset value stored in nonvolatile memory; then during system operation minor adjustments could be made. The adjustments might be based on user preference: system parameter changes due to temperature drift, etc.

The state of  $U/\overline{D}$  may be changed while  $\overline{CS}$  remains LOW. This allows the host system to enable the device and then move the wiper up and down until the proper trim is attained.

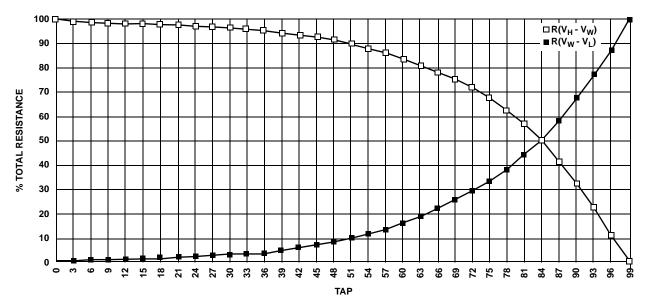
### Mode Selection

CS	INC	U/D	MODE
L		Н	Wiper Up
L	1	L	Wiper Down
_	Н	Х	Store Wiper Position
Н	Х	Х	Standby Current
	L	Х	No Store, Return to Standby
~	L	Н	Wiper Up (not recommended)
~	L	L	Wiper Down (not recommended)

# Symbol Table

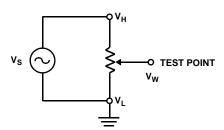
WAVEFORM	INPUTS	OUTPUTS
	Must be steady	Will be steady
	May change from Low to High	Will change from Low to High
	May change from High to Low	Will change from High to Low
	Don't Care: Changes Allowed	Changing: State Not Known
	N/A	Center Line is High Impedance

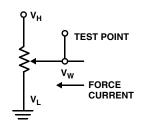
# Typical Electrical Taper



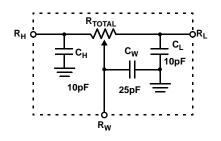
Test Circuit #1

Test Circuit #2





#### Circuit #3 SPICE Macro Model



#### **Absolute Maximum Ratings**

Temperature Under Bias65°C to +135°C
Storage Temperature
Voltage on $\overline{CS}$ , $\overline{INC}$ , U/D and V <sub>CC</sub> with Respect to V <sub>SS</sub> 1V to +7V
Voltage on V <sub>H</sub> and V <sub>L</sub> Referenced to V <sub>SS</sub> 8V to +8V
$\Delta V =  V_{H} - V_{L}  X9C303 \dots 10V$
Wiper Current

#### **Thermal Information**

\*Pb-free PDIPs can be used for through hole wave solder processing only. They are not intended for use in Reflow solder processing applications.

#### **Recommended Operating Conditions**

CAUTION: Do not operate at or near the maximum ratings listed for extended periods of time. Exposure to such conditions may adversely impact product reliability and result in failures not covered by warranty.

#### **Analog Specifications**

Over recommended operating conditions, unless otherwise specified. Parameters with MIN and/or MAX limits are 100% tested at +25°C, unless otherwise specified. Temperature limits established by characterization and are not production tested.

	PARAMETER		LIMITS			
SYMBOL		TEST CONDITIONS	MIN	TYP (Note 3)	МАХ	UNIT
R <sub>TOTAL</sub>	End-to-End Resistance			32		κΩ
	End-to-End Resistance Tolerance		-15		+15	%
VH	V <sub>H</sub> Terminal Voltage		-5		+5	V
VL	V <sub>L</sub> Terminal Voltage		-5		+5	V
RW	Wiper Resistance	Max Wiper Current ±1mA		40	100	Ω
	Tap Position Relative Step Size Error	Error = log (Vw(n)) - log (Vw(n - 1)) for tap n = 2 - 99, V <sub>H</sub> -V <sub>L</sub> = 10V	0.005		0.115	dB
	Resistor Noise	At 1kHz		23		nV(RMS)/ √Hz
	Charge Pump Noise	At 850kHz		20		mV(RMS)
	End-to-End Resistance Temperature Coefficient	$T = -40^{\circ}C \text{ to } +85^{\circ}C$		±400		ppm/°C
	Ratiometric Temperature Coefficient	Tap position 84		±20		ppm/°C
C <sub>H</sub> /C <sub>L</sub> /C <sub>W</sub> (Note 5)	Potentiometer Capacitance	See "Circuit #3 SPICE Macro Model" on page 4		10/10/25		pF

# **DC Electrical Specifications**

Over recommended operating conditions, unless otherwise specified. Parameters with MIN and/or MAX limits are 100% tested at +25°C, unless otherwise specified. Temperature limits established by characterization and are not production tested.

				LIMITS	LIMITS	
SYMBOL	PARAMETER	TEST CONDITIONS	MIN	TYP (Note 3)	МАХ	UNIT
ICC	V <sub>CC</sub> Active Current	$\overline{CS} = V_{IL}, U/\overline{D} = V_{IL} \text{ or } V_{IH} \text{ and}$ INC = 0.4V to 2.4V @ Max t <sub>CYC</sub>		1	3	mA
I <sub>SB</sub>	Standby Supply Current	$\overline{CS} = V_{CC} - 0.3V$ , U/ $\overline{D}$ and $\overline{INC} = V_{SS}$ or $V_{CC} - 0.3V$		200	750	μA
ΙLI	CS, INC, U/D Input Leakage Current	VIN = VSS to VCC	-10		+10	μA
VIH	CS, INC, U/D Input HIGH Voltage		2			V
VIL	CS, INC, U/D Input LOW voltage				0.8	V
C <sub>IN</sub> (Note 5)	CS, INC, U/D Input Capacitance	$V_{CC} = 5V$ , $V_{IN} = V_{SS}$ , $T_A = +25^{\circ}C$ , f = 1MHz		10		pF
EEPROM SPE	cs					4
	EEPROM Endurance	Wiper storage operations over recommended operation conditions	100,000			Cycles
	EEPROM Retention	At +55°C		100		Years

NOTES:

3. Typical values are for  $T_A = +25^{\circ}C$  and nominal supply voltage.

#### **Standard Parts**

PART NUMBER	PART NUMBER MAXIMUM RESISTANCE		MINIMUM RESISTANCE	
X9C303	<b>32k</b> Ω	Log Taper	40Ω Typical	

### **AC Conditions of Test**

Input Pulse Levels	0V to 3V
Input Rise and Fall Times	10ns
Input Reference Levels	1.5V

#### **AC Electrical Specifications**

Over recommended operating conditions, unless otherwise specified. Parameters with MIN and/or MAX limits are 100% tested at +25°C, unless otherwise specified. Temperature limits established by characterization and are not production tested.

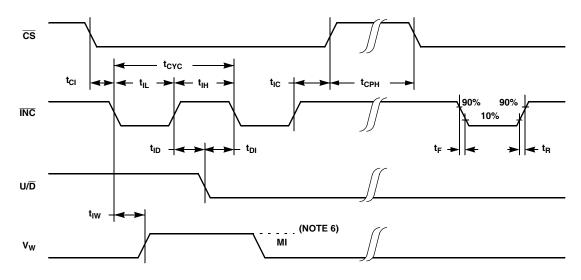
		LIMITS			
SYMBOL	PARAMETER	MIN	TYP (Note 4)	МАХ	UNIT
<sup>t</sup> Cl	CS to INC Set-up	100			ns
tιD	INC HIGH to U/D Change	100			ns
<sup>t</sup> DI	$U/\overline{D}$ to $\overline{INC}$ Set-up	2.9			μs
tIL	INC LOW Period	1			μs
tιΗ	INC HIGH Period	1			μs
ťΙC	INC Inactive to CS Inactive	1			μs
<sup>t</sup> CPH	CS Deselect Time	20			ms
tIW (Note 5)	INC to V <sub>W</sub> Change		100		μs
<sup>t</sup> CYC	INC Cycle Time	2			μs

# **AC Electrical Specifications**

Over recommended operating conditions, unless otherwise specified. Parameters with MIN and/or MAX limits are 100% tested at +25°C, unless otherwise specified. Temperature limits established by characterization and are not production tested. **(Continued)** 

			LIMITS		
SYMBOL	PARAMETER	MIN	TYP (Note 4)	МАХ	UNIT
t <sub>R,</sub> t <sub>F</sub> (Note 5)	INC Input Rise and Fall Time			500	ns
tPU (Note 5)	Power-up to Wiper Stable		500		μs
t <sub>R</sub> V <sub>CC</sub> (Note 5)	V <sub>CC</sub> Power-up Rate	0.2		50	mV/µs

# AC Timing Diagram

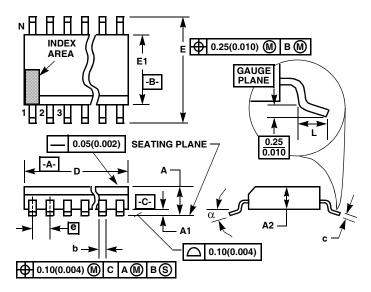


NOTES:

- 4. Typical values are for  $T_A = +25^{\circ}C$  and nominal supply voltage.
- 5. This parameter is not 100% tested.

6. MI in the "AC Timing Diagram" refers to the minimum incremental change in the  $V_W$  output due to a change in the wiper position.

# Thin Shrink Small Outline Plastic Packages (TSSOP)



#### NOTES:

- 1. These package dimensions are within allowable dimensions of JEDEC MO-153-AC, Issue E.
- 2. Dimensioning and tolerancing per ANSI Y14.5M-1982.
- Dimension "D" does not include mold flash, protrusions or gate burrs. Mold flash, protrusion and gate burrs shall not exceed 0.15mm (0.006 inch) per side.
- Dimension "E1" does not include interlead flash or protrusions. Interlead flash and protrusions shall not exceed 0.15mm (0.006 inch) per side.
- 5. The chamfer on the body is optional. If it is not present, a visual index feature must be located within the crosshatched area.
- 6. "L" is the length of terminal for soldering to a substrate.
- 7. "N" is the number of terminal positions.
- 8. Terminal numbers are shown for reference only.
- 9. Dimension "b" does not include dambar protrusion. Allowable dambar protrusion shall be 0.08mm (0.003 inch) total in excess of "b" dimension at maximum material condition. Minimum space between protrusion and adjacent lead is 0.07mm (0.0027 inch).
- 10. Controlling dimension: MILLIMETER. Converted inch dimensions are not necessarily exact. (Angles in degrees)

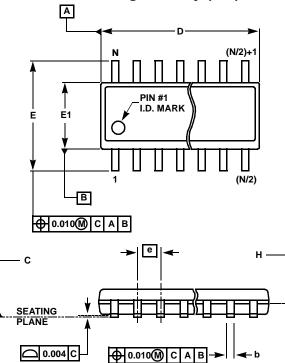
#### M8.173

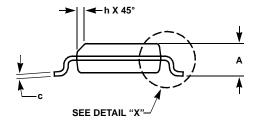
# 8 LEAD THIN SHRINK NARROW BODY SMALL OUTLINE PLASTIC PACKAGE

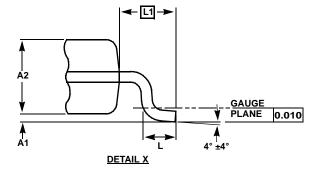
MIN - 0.05 0.80 0.19 0.09	MAX 1.20 0.15 1.05 0.30 0.20	<b>NOTES</b> 9
0.80 0.19	0.15 1.05 0.30	- - - 9
0.80 0.19	1.05 0.30	- - 9
0.19	0.30	- 9
		9
0.09	0.20	
	0.20	-
2.95	3.05	3
4.30	4.50	4
0.65	-	
6.25	6.50	-
0.45	0.75	6
8	7	
00	8º	-
	6.25 0.45	0.45 0.75

Rev. 1 12/00









## MDP0027

SMALL OUTLINE PACKAGE FAMILY (SO)

				INCHES					
SYMBOL	SO-8	SO-14	SO16 (0.150")	SO16 (0.300") (SOL-16)	SO20 (SOL-20)	SO24 (SOL-24)	SO28 (SOL-28)	TOLERANCE	NOTES
А	0.068	0.068	0.068	0.104	0.104	0.104	0.104	MAX	-
A1	0.006	0.006	0.006	0.007	0.007	0.007	0.007	±0.003	-
A2	0.057	0.057	0.057	0.092	0.092	0.092	0.092	±0.002	-
b	0.017	0.017	0.017	0.017	0.017	0.017	0.017	±0.003	-
С	0.009	0.009	0.009	0.011	0.011	0.011	0.011	±0.001	-
D	0.193	0.341	0.390	0.406	0.504	0.606	0.704	±0.004	1, 3
Е	0.236	0.236	0.236	0.406	0.406	0.406	0.406	±0.008	-
E1	0.154	0.154	0.154	0.295	0.295	0.295	0.295	±0.004	2, 3
е	0.050	0.050	0.050	0.050	0.050	0.050	0.050	Basic	-
L	0.025	0.025	0.025	0.030	0.030	0.030	0.030	±0.009	-
L1	0.041	0.041	0.041	0.056	0.056	0.056	0.056	Basic	-
h	0.013	0.013	0.013	0.020	0.020	0.020	0.020	Reference	-
Ν	8	14	16	16	20	24	28	Reference	-

Rev. M 2/07

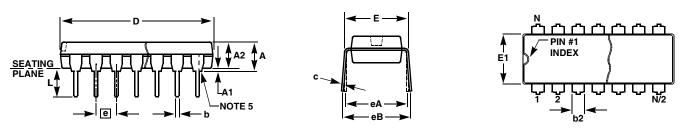
NOTES:

- 1. Plastic or metal protrusions of 0.006" maximum per side are not included.
- 2. Plastic interlead protrusions of 0.010" maximum per side are not included.
- 3. Dimensions "D" and "E1" are measured at Datum Plane "H".

9

4. Dimensioning and tolerancing per ASME Y14.5M-1994

# Plastic Dual-In-Line Packages (PDIP)



#### MDP0031 PLASTIC DUAL-IN-LINE PACKAGE

NOTES	TOLERANCE						
		PDIP20	PDIP18	PDIP16	PDIP14	PDIP8	SYMBOL
	MAX	0.210	0.210	0.210	0.210	0.210	А
	MIN	0.015	0.015	0.015	0.015	0.015	A1
	±0.005	0.130	0.130	0.130	0.130	0.130	A2
	±0.002	0.018	0.018	0.018	0.018	0.018	b
	+0.010/-0.015	0.060	0.060	0.060	0.060	0.060	b2
	+0.004/-0.002	0.010	0.010	0.010	0.010	0.010	С
1	±0.010	1.020	0.890	0.750	0.750	0.375	D
	+0.015/-0.010	0.310	0.310	0.310	0.310	0.310	Е
2	±0.005	0.250	0.250	0.250	0.250	0.250	E1
	Basic	0.100	0.100	0.100	0.100	0.100	е
	Basic	0.300	0.300	0.300	0.300	0.300	eA
	±0.025	0.345	0.345	0.345	0.345	0.345	eB
	±0.010	0.125	0.125	0.125	0.125	0.125	L
	Reference	20	18	16	14	8	N

NOTES:

- 1. Plastic or metal protrusions of 0.010" maximum per side are not included.
- 2. Plastic interlead protrusions of 0.010" maximum per side are not included.
- 3. Dimensions E and eA are measured with the leads constrained perpendicular to the seating plane.
- 4. Dimension eB is measured with the lead tips unconstrained.
- 5. 8 and 16 lead packages have half end-leads as shown.

All Intersil U.S. products are manufactured, assembled and tested utilizing ISO9000 quality systems. Intersil Corporation's quality certifications can be viewed at www.intersil.com/design/quality

Intersil products are sold by description only. Intersil Corporation reserves the right to make changes in circuit design, software and/or specifications at any time without notice. Accordingly, the reader is cautioned to verify that data sheets are current before placing orders. Information furnished by Intersil is believed to be accurate and reliable. However, no responsibility is assumed by Intersil or its subsidiaries for its use; nor for any infringements of patents or other rights of third parties which may result from its use. No license is granted by implication or otherwise under any patent or patent rights of Intersil or its subsidiaries.

For information regarding Intersil Corporation and its products, see www.intersil.com

